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TECHNICAL SPECIFICATION

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**Satellite Access Node conformance testing
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Contents

Intellectual Property Rights	2
Legal Notice	2
Modal verbs terminology.....	2
Foreword.....	15
1 Scope	17
2 References	17
3 Definitions of terms, symbols and abbreviations	18
3.1 Terms.....	18
3.2 Symbols.....	21
3.3 Abbreviations	22
4 General test conditions and declarations	23
4.1 Measurement uncertainties and test requirements	23
4.1.1 General.....	23
4.1.2 Acceptable uncertainty of Test System.....	24
4.1.2.1 General	24
4.1.2.2 Measurement of transmitter	25
4.1.2.3 Measurement of receiver	26
4.1.2.4 Measurement of performance requirements.....	28
4.1.3 Interpretation of measurement results.....	28
4.2 Requirement reference points.....	29
4.2.1 SAN type 1-H	29
4.2.2 SAN type 1-O	30
4.3 Satellite Access Node classes.....	30
4.4 Regional requirements.....	31
4.5 SAN configurations	31
4.5.1 SAN type 1-H transmit configurations	31
4.5.2 SAN type 1-H receive configurations	31
4.5.3 SAN type 1-O transmit configurations	32
4.5.4 SAN type 1-O receive configurations	32
4.5.5 Power supply options.....	33
4.6 Manufacturer declarations	33
4.7 Test configurations	42
4.7.1 General.....	42
4.7.2 Test signal used to build Test Configurations.....	42
4.7.3 NRTC1: Contiguous spectrum operation.....	42
4.7.3.1 NRTC1 generation	42
4.7.3.2 NRTC1 power allocation	42
4.8 Applicability of requirements.....	43
4.8.1 General.....	43
4.8.2 Requirement set applicability	43
4.8.3 Applicability of test configurations for single-band operation	44
4.9 RF channels and test models	45
4.9.1 RF channels	45
4.9.2 Test models	45
4.9.2.1 General	45
4.9.2.2 FR1 test models.....	45
4.9.2.2.1 FR1 test model 1.1 (NR-SAN-FR1-TM1.1).....	46
4.9.2.2.2 FR1 test model 1.2 (NR-SAN-FR1-TM1.2).....	47
4.9.2.2.3 FR1 test model 2 (NR-SAN-FR1-TM2).....	47
4.9.2.2.4 FR1 test model 3.1 (NR-SAN-FR1-TM3.1).....	48
4.9.2.2.5 FR1 test model 3.2 (NR-SAN-FR1-TM3.2).....	48
4.9.2.2.6 FR1 test model 3.3 (NR-SAN-FR1-TM3.3).....	49
4.9.2.3 Data content of Physical channels and Signals for NR-SAN-FR1-TM	50
4.9.2.3.1 PDCCH.....	50

4.9.2.3.2	PDSCH	50
4.10	Void.....	51
4.11	Reference coordinate system	51
4.12	Format and interpretation of tests.....	52
5	Operating bands and channel arrangement.....	53
6	Conducted transmitter characteristics	53
6.1	General	53
6.1.1	SAN type 1-H	53
6.2	Satellite Access Node output power	53
6.2.1	Definition and applicability	53
6.2.2	Minimum requirement	54
6.2.3	Test purpose.....	54
6.2.4	Method of test	54
6.2.4.1	Initial conditions	54
6.2.4.2	Procedure	54
6.2.5	Test requirement	55
6.3	Output power dynamics.....	55
6.3.1	General.....	55
6.3.2	RE power control dynamic range	55
6.3.2.1	Definition and applicability.....	55
6.3.2.2	Minimum requirement	55
6.3.2.3	Test purpose	55
6.3.3	Total power dynamic range	55
6.3.3.1	Definition and applicability.....	55
6.3.3.2	Minimum requirement	55
6.3.3.3	Test purpose	56
6.3.3.4	Method of test	56
6.3.3.4.1	Initial conditions	56
6.3.3.4.2	Procedure.....	56
6.3.3.5	Test requirements	56
6.4	Transmit ON/OFF power	57
6.5	Transmitted signal quality	57
6.5.1	General.....	57
6.5.2	Frequency error.....	57
6.5.2.1	Definition and applicability.....	57
6.5.2.2	Minimum Requirement	57
6.5.2.3	Test purpose	57
6.5.2.4	Method of test	57
6.5.2.5	Test Requirements.....	57
6.5.3	Modulation quality.....	58
6.5.3.1	Definition and applicability.....	58
6.5.3.2	Minimum Requirement	58
6.5.3.3	Test purpose	58
6.5.3.4	Method of test	58
6.5.3.4.1	Initial conditions	58
6.5.3.4.2	Procedure.....	58
6.5.3.5	Test requirements	59
6.6	Unwanted emissions.....	60
6.6.1	General.....	60
6.6.2	Occupied bandwidth	60
6.6.2.1	Definition and applicability.....	60
6.6.2.2	Minimum requirements	60
6.6.2.3	Test purpose	60
6.6.2.4	Method of test	60
6.6.2.4.1	Initial conditions	60
6.6.2.4.2	Procedure.....	61
6.6.2.5	Test requirements	61
6.6.3	Adjacent Channel Leakage Power Ratio (ACLR)	61
6.6.3.1	Definition and applicability.....	61
6.6.3.2	Minimum requirement	61

6.6.3.3	Test purpose	62
6.6.3.4	Method of test	62
6.6.3.4.1	Initial conditions	62
6.6.3.4.2	Procedure	62
6.6.3.5	Test requirements	62
6.6.3.5.1	General requirements	62
6.6.3.5.2	Limits	62
6.6.4	Out-of-band emissions	63
6.6.4.1	Definition and applicability	63
6.6.4.2	Minimum requirement	63
6.6.4.3	Test purpose	64
6.6.4.4	Method of test	64
6.6.4.4.1	Initial conditions	64
6.6.4.4.2	Procedure	64
6.6.4.5	Test requirements	64
6.6.5	Transmitter spurious emissions	65
6.6.5.1	Definition and applicability	65
6.6.5.2	Minimum requirement	65
6.6.5.3	Test purpose	65
6.6.5.4	Method of test	65
6.6.5.4.1	Initial conditions	65
6.6.5.4.2	Procedure	66
6.6.5.5	Test requirements	66
6.6.5.5.1	Basic limits	66
6.7	Transmitter intermodulation	66
7	Conducted receiver characteristics	67
7.1	General	67
7.2	Reference sensitivity level	67
7.2.1	Definition and applicability	67
7.2.2	Minimum requirement	67
7.2.3	Test purpose	67
7.2.4	Method of test	67
7.2.4.1	Initial conditions	67
7.2.4.2	Procedure	67
7.2.5	Test requirements	68
7.3	Dynamic range	69
7.3.1	Definition and applicability	69
7.3.2	Minimum requirement	69
7.3.3	Test purpose	69
7.3.4	Method of test	69
7.3.4.1	Initial conditions	69
7.3.4.2	Procedure	69
7.3.5	Test requirements	69
7.4	In-band sensitivity and blocking	70
7.4.1	Adjacent Channel Selectivity (ACS)	70
7.4.1.1	Definition and applicability	70
7.4.1.2	Minimum requirement	70
7.4.1.3	Test purpose	70
7.4.1.4	Method of test	70
7.4.1.4.1	Initial conditions	70
7.4.1.4.2	Procedure	70
7.4.1.5	Test requirements	71
7.4.2	In-band blocking	71
7.5	Out-of-band blocking	72
7.5.1	Definition and applicability	72
7.5.2	Minimum requirement	72
7.5.3	Test purpose	72
7.5.4	Method of test	72
7.5.4.1	Initial conditions	72
7.5.4.2	Procedure	72
7.5.5	Test requirements	72

7.6	Receiver spurious emission	73
7.7	Receiver intermodulation	73
7.8	In-channel selectivity	73
7.8.1	Definition and applicability	73
7.8.2	Minimum requirement	73
7.8.3	Test purpose	73
7.8.4	Method of test	73
7.8.4.1	Initial conditions	73
7.8.4.2	Procedure	73
7.8.5	Test requirements	74
8	Conducted performance characteristics	75
8.1	General	75
8.1.1	Scope and definitions	75
8.1.2	Applicability rule	76
8.1.2.1	General	76
8.1.2.2	Applicability of PUSCH performance requirements	76
8.1.2.2.1	Applicability of requirements for different subcarrier spacings	76
8.1.2.2.2	Applicability of requirements for different channel bandwidths	76
8.1.2.2.3	Applicability of requirements for different configurations	76
8.1.2.2.4	Applicability of PUSCH repetition type A requirements	76
8.1.2.3	Applicability of PUCCH performance requirements	76
8.1.2.3.1	Applicability of requirements for different formats	76
8.1.2.3.2	Applicability of requirements for different subcarrier spacings	76
8.1.2.3.3	Applicability of requirements for different channel bandwidths	76
8.1.2.3.4	Applicability of requirements for different configurations	77
8.1.2.3.5	Applicability of requirements for multi-slot PUCCH	77
8.1.2.4	Applicability of PRACH performance requirements	77
8.1.2.4.1	Applicability of requirements for different formats	77
8.1.2.4.2	Applicability of requirements for different subcarrier spacings	77
8.1.2.4.3	Applicability of requirements for different channel bandwidths	77
8.2	Performance requirements for PUSCH	77
8.2.1	Performance requirements for PUSCH with transform precoding disabled	77
8.2.1.1	Definition and applicability	77
8.2.1.2	Minimum Requirement	77
8.2.1.3	Test Purpose	77
8.2.1.4	Method of test	78
8.2.1.4.1	Initial Conditions	78
8.2.1.4.2	Procedure	78
8.2.1.5	Test Requirement	79
8.2.2	Performance requirements for PUSCH with transform precoding enabled	80
8.2.2.1	Definition and applicability	80
8.2.2.2	Minimum Requirement	80
8.2.2.3	Test Purpose	80
8.2.2.4	Method of test	80
8.2.2.4.1	Initial Conditions	80
8.2.2.4.2	Procedure	80
8.2.2.5	Test Requirement	81
8.2.3	Performance requirements for UL timing adjustment	82
8.2.3.1	Definition and applicability	82
8.2.3.2	Minimum Requirement	83
8.2.3.3	Test Purpose	83
8.2.3.4	Method of test	83
8.2.3.4.1	Initial Conditions	83
8.2.3.4.2	Procedure	83
8.2.3.5	Test Requirement for Normal Mode	84
8.2.4	Performance requirements for PUSCH repetition Type A	85
8.2.4.1	Definition and applicability	85
8.2.4.2	Minimum Requirement	85
8.2.4.3	Test Purpose	85
8.2.4.4	Method of test	85
8.2.4.4.1	Initial Conditions	85

8.2.4.4.2	Procedure	85
8.2.4.5	Test Requirement	86
8.3	Performance requirements for PUCCH	87
8.3.1	Performance requirements for PUCCH format 0	87
8.3.1.1	Definition and applicability	87
8.3.1.2	Minimum Requirement	87
8.3.1.3	Test purpose	87
8.3.1.4	Method of test	87
8.3.1.4.1	Initial conditions	87
8.3.1.4.2	Procedure	88
8.3.1.5	Test Requirement	88
8.3.2	Performance requirements for PUCCH format 1	89
8.3.2.1	NACK to ACK detection	89
8.3.2.1.1	Definition and applicability	89
8.3.2.1.2	Minimum Requirement	89
8.3.2.1.3	Test purpose	89
8.3.2.1.4	Method of test	89
8.3.2.1.4.1	Initial Conditions	89
8.3.2.1.4.2	Procedure	90
8.3.2.1.5	Test Requirement	90
8.3.2.2	ACK missed detection	91
8.3.2.2.1	Definition and applicability	91
8.3.2.2.2	Minimum Requirement	91
8.3.2.2.3	Test purpose	91
8.3.2.2.4	Method of test	91
8.3.2.2.4.1	Initial Conditions	91
8.3.2.2.4.2	Procedure	91
8.3.2.2.5	Test Requirement	92
8.3.3	Performance requirements for PUCCH format 2	93
8.3.3.1	ACK missed detection	93
8.3.3.1.1	Definition and applicability	93
8.3.3.1.2	Minimum requirements	93
8.3.3.1.3	Test purpose	93
8.3.3.1.4	Method of test	93
8.3.3.1.4.1	Initial Condition	93
8.3.3.1.4.2	Procedure	93
8.3.3.1.5	Test requirements	94
8.3.3.2	UCI BLER performance requirements	95
8.3.3.2.1	Definition and applicability	95
8.3.3.2.2	Minimum Requirement	95
8.3.3.2.3	Test purpose	95
8.3.3.2.4	Method of test	95
8.3.3.2.4.1	Initial Condition	95
8.3.3.2.4.2	Procedure	95
8.3.3.2.5	Test requirements	96
8.3.4	Performance requirements for PUCCH format 3	96
8.3.4.1	Definition and applicability	96
8.3.4.2	Minimum requirement	97
8.3.4.3	Test purpose	97
8.3.4.4	Method of test	97
8.3.4.4.1	Initial conditions	97
8.3.4.4.2	Procedure	97
8.3.4.5	Test requirement	98
8.3.5	Performance requirements for PUCCH format 4	98
8.3.5.1	Definition and applicability	98
8.3.5.2	Minimum requirement	98
8.3.5.3	Test purpose	98
8.3.5.4	Method of test	99
8.3.5.4.1	Initial conditions	99
8.3.5.4.2	Procedure	99
8.3.5.5	Test requirement	100
8.3.6	Performance requirements for multi-slot PUCCH	100

8.3.6.1	Performance requirements for multi-slot PUCCH format 1	100
8.3.6.1.1	NACK to ACK detection	100
8.3.6.1.1.1	Definition and applicability	100
8.3.6.1.1.2	Minimum Requirement	100
8.3.6.1.1.3	Test purpose	100
8.3.6.1.1.4	Method of test	101
8.3.6.1.1.4.1	Initial conditions	101
8.3.6.1.1.4.2	Procedure	101
8.3.6.1.1.5	Test Requirement	101
8.3.6.1.2	ACK missed detection	102
8.3.6.1.2.1	Definition and applicability	102
8.3.6.1.2.2	Minimum Requirement	102
8.3.6.1.2.3	Test purpose	102
8.3.6.1.2.4	Method of test	102
8.3.6.1.2.4.1	Initial conditions	102
8.3.6.1.2.4.2	Procedure	102
8.3.6.1.2.5	Test Requirement	103
8.4	Performance requirements for PRACH	104
8.4.1	PRACH false alarm probability and missed detection	104
8.4.1.1	Definition and applicability	104
8.4.1.2	Minimum requirement	104
8.4.1.3	Test purpose	104
8.4.1.4	Method of test	104
8.4.1.4.1	Initial conditions	104
8.4.1.4.2	Procedure	105
8.4.1.5	Test requirement for Normal Mode	106
9	Radiated transmitter characteristics	107
9.1	General	107
9.2	Radiated transmit power	107
9.2.1	Definition and applicability	107
9.2.2	Minimum requirement	107
9.2.3	Test purpose	107
9.2.4	Method of test	107
9.2.4.1	Initial conditions	107
9.2.4.2	Procedure	108
9.2.5	Test requirement	108
9.3	OTA SAN output power	108
9.3.1	Definition and applicability	108
9.3.2	Minimum requirement	108
9.3.3	Test purpose	108
9.3.4	Method of test	109
9.3.4.1	Initial conditions	109
9.3.4.2	Procedure	109
9.3.5	Test requirement	109
9.4	OTA output power dynamics	109
9.4.1	General	109
9.4.2	OTA RE power control dynamic range	110
9.4.2.1	Definition and applicability	110
9.4.2.2	Minimum requirement	110
9.4.2.3	Method of test	110
9.4.3	OTA total power dynamic range	110
9.4.3.1	Definition and applicability	110
9.4.3.2	Minimum requirement	110
9.4.3.3	Test purpose	110
9.4.3.4	Method of test	110
9.4.3.4.1	Initial conditions	110
9.4.3.4.2	Procedure	111
9.4.3.5	Test requirement	111
9.4.3.5.1	SAN type 1-O	111
9.5	OTA transmit ON/OFF power	112
9.6	OTA transmitted signal quality	112

9.6.1	General.....	112
9.6.2	OTA frequency error	112
9.6.2.1	Definition and applicability.....	112
9.6.2.2	Minimum Requirement	112
9.6.2.3	Test purpose	112
9.6.2.4	Method of test	112
9.6.2.4.1	Initial conditions.....	112
9.6.2.5	Test Requirements.....	112
9.6.3	OTA modulation quality	112
9.6.3.1	Definition and applicability.....	112
9.6.3.2	Minimum Requirement	113
9.6.3.3	Test purpose	113
9.6.3.4	Method of test	113
9.6.3.4.1	Initial conditions.....	113
9.6.3.4.2	Procedure.....	113
9.6.3.5	Test requirements.....	114
9.6.3.5.1	<i>SAN type 1-O</i>	114
9.7	OTA unwanted emissions	115
9.7.1	General.....	115
9.7.2	OTA occupied bandwidth.....	115
9.7.2.1	General	115
9.7.2.2	Minimum requirement	115
9.7.2.3	Test purpose	115
9.7.2.4	Method of test	116
9.7.2.4.1	Initial conditions.....	116
9.7.2.4.2	Procedure.....	116
9.7.2.5	Test requirement	117
9.7.3	OTA Adjacent Channel Leakage Power Ratio (ACLR).....	117
9.7.3.1	Definition and applicability.....	117
9.7.3.2	Minimum requirement	117
9.7.3.3	Test purpose	117
9.7.3.4	Method of test	117
9.7.3.4.1	Initial conditions.....	117
9.7.3.4.2	Procedure.....	117
9.7.3.5	Test requirements.....	118
9.7.4	OTA out-of-band emissions.....	119
9.7.4.1	Definition and applicability.....	119
9.7.4.2	Minimum requirement	119
9.7.4.3	Test purpose	119
9.7.4.4	Method of test	119
9.7.4.4.1	Initial conditions.....	119
9.7.4.4.2	Procedure.....	119
9.7.4.5	Test requirements.....	120
9.7.5	OTA transmitter spurious emissions.....	120
9.7.5.1	General	120
9.7.5.2	General OTA transmitter spurious emissions requirements.....	121
9.7.5.2.1	Definition and applicability	121
9.7.5.2.2	Minimum requirement	121
9.7.5.2.3	Test purpose	121
9.7.5.2.4	Method of test.....	121
9.7.5.2.4.1	Initial conditions	121
9.7.5.2.4.2	Procedure	121
9.7.5.2.5	Test requirement	122
9.7.5.2.5.1	Test requirement for <i>SAN type 1-O</i>	122
9.8	OTA transmitter intermodulation	122
10	Radiated receiver characteristic.....	122
10.1	General	122
10.2	OTA sensitivity	123
10.2.1	Definition and applicability	123
10.2.2	Minimum requirement	124
10.2.3	Test Purpose.....	124

10.2.4	Method of test	124
10.2.4.1	Initial conditions	124
10.2.4.2	Procedure	124
10.2.5	Test requirements.....	125
10.2.5.1	General	125
10.2.5.2	Test requirements for <i>SAN type I-H</i> and <i>SAN type I-O</i>	125
10.3	OTA reference sensitivity level.....	125
10.3.1	Definition and applicability	125
10.3.2	Minimum requirement	125
10.3.3	Test Purpose.....	125
10.3.4	Method of test	126
10.3.4.1	Initial conditions	126
10.3.4.2	Procedure	126
10.3.5	Test requirements.....	126
10.3.5.1	General	126
10.3.5.2	Test requirements for <i>SAN type I-O</i>	126
10.4	OTA dynamic range	127
10.4.1	Definition and applicability	127
10.4.2	Minimum requirement	127
10.4.3	Test purpose.....	127
10.4.4	Method of test	128
10.4.4.1	Initial conditions	128
10.4.4.2	Procedure	128
10.4.5	Test requirement	128
10.4.5.1	General	128
10.4.5.2	Test requirements for <i>SAN type I-O</i>	128
10.5	OTA in-band selectivity and blocking.....	129
10.5.1	OTA adjacent channel selectivity	129
10.5.1.1	Definition and applicability.....	129
10.5.1.2	Minimum requirement	129
10.5.1.3	Test purpose	129
10.5.1.4	Method of test	129
10.5.1.4.1	Initial conditions	129
10.5.1.4.2	Procedure.....	130
10.5.1.5	Test requirement	130
10.5.1.5.1	General	130
10.5.1.5.2	Test requirements for <i>SAN type I-O</i>	130
10.5.2	OTA in-band blocking.....	131
10.6	OTA out-of-band blocking	131
10.6.1	Definition and applicability	131
10.6.2	Minimum requirement	131
10.6.3	Test purpose.....	131
10.6.4	Method of test	131
10.6.4.1	Initial conditions	131
10.6.4.2	Procedure	132
10.6.5	Test requirements.....	132
10.7	OTA receiver spurious emissions.....	133
10.8	OTA receiver intermodulation	133
10.9	OTA in-channel selectivity.....	133
10.9.1	Definition and applicability	133
10.9.2	Minimum requirement	133
10.9.3	Test purpose.....	133
10.9.4	Method of test	133
10.9.4.1	Initial conditions	133
10.9.4.2	Procedure	134
10.9.5	Test requirement	134
10.9.5.1	<i>SAN type I-O</i>	134
11	Radiated performance requirements.....	135
11.1	General	135
11.1.1	Scope and definitions.....	135
11.1.2	OTA demodulation branches	136

11.1.3	Applicability rule	136
11.1.3.1	General	136
11.1.3.2	Applicability of PUSCH performance requirements	136
11.1.3.2.1	Applicability of requirements for different subcarrier spacings	136
11.1.3.2.2	Applicability of requirements for different channel bandwidths	137
11.1.3.2.3	Applicability of requirements for different configurations	137
11.1.3.2.4	Applicability of PUSCH repetition type A requirements	137
11.1.3.3	Applicability of PUCCH performance requirements	137
11.1.3.3.1	Applicability of requirements for different formats	137
11.1.3.3.2	Applicability of requirements for different subcarrier spacings	137
11.1.3.3.3	Applicability of requirements for different channel bandwidths	137
11.1.3.3.4	Applicability of requirements for different configurations	137
11.1.3.3.5	Applicability of requirements for multi-slot PUCCH	137
11.1.3.4	Applicability of PRACH performance requirements	138
11.1.3.4.1	Applicability of requirements for different formats	138
11.1.3.4.2	Applicability of requirements for different subcarrier spacings	138
11.1.3.4.3	Applicability of requirements for different channel bandwidths	138
11.2	OTA performance requirements for PUSCH	138
11.2.1	Performance requirements for PUSCH with transform precoding disabled	138
11.2.1.1	Definition and applicability	138
11.2.1.2	Minimum Requirement	138
11.2.1.3	Test Purpose	138
11.2.1.4	Method of test	138
11.2.1.4.1	Initial Conditions	138
11.2.1.4.2	Procedure	138
11.2.1.5	Test Requirement	139
11.2.2	Performance requirements for PUSCH with transform precoding enabled	141
11.2.2.1	Definition and applicability	141
11.2.2.2	Minimum Requirement	141
11.2.2.3	Test Purpose	141
11.2.2.4	Method of test	141
11.2.2.4.1	Initial Conditions	141
11.2.2.4.2	Procedure	141
11.2.2.5	Test Requirement	142
11.2.3	Performance requirements for UL timing adjustment	144
11.2.3.1	Definition and applicability	144
11.2.3.2	Minimum Requirement	144
11.2.3.3	Test Purpose	144
11.2.3.4	Method of test	144
11.2.3.4.1	Initial Conditions	144
11.2.3.4.2	Procedure	144
11.2.3.5	Test Requirement	145
11.2.4	Performance requirements for PUSCH repetition Type A	146
11.2.4.1	Definition and applicability	146
11.2.4.2	Minimum Requirement	146
11.2.4.3	Test Purpose	146
11.2.4.4	Method of test	147
11.2.4.4.1	Initial Conditions	147
11.2.4.4.2	Procedure	147
11.2.4.5	Test Requirement	148
11.3	OTA performance requirements for PUCCH	149
11.3.1	Performance requirements for PUCCH format 0	149
11.3.1.1	Definition and applicability	149
11.3.1.2	Minimum Requirement	149
11.3.1.3	Test purpose	149
11.3.1.4	Method of test	149
11.3.1.4.1	Initial conditions	149
11.3.1.4.2	Procedure	149
11.3.1.5	Test Requirement	150
11.3.1.5.1	Test requirement for <i>SAN type I-O</i>	150
11.3.2	Performance requirements for PUCCH format 1	151
11.3.2.1	NACK to ACK detection	151

11.3.2.1.1	Definition and applicability	151
11.3.2.1.2	Minimum Requirement	151
11.3.2.1.3	Test purpose	151
11.3.2.1.4	Method of test.....	151
11.3.2.1.4.1	Initial Conditions	151
11.3.2.1.4.2	Procedure	152
11.3.2.1.5	Test Requirement.....	153
11.3.2.2	ACK missed detection.....	153
11.3.2.2.1	Definition and applicability	153
11.3.2.2.2	Minimum Requirement	153
11.3.2.2.3	Test purpose	153
11.3.2.2.4	Method of test.....	153
11.3.2.2.4.1	Initial Conditions	153
11.3.2.2.4.2	Procedure	154
11.3.2.2.5	Test Requirement.....	155
11.3.3	Performance requirements for PUCCH format 2.....	155
11.3.3.1	ACK missed detection performance requirements	155
11.3.3.1.1	Definition and applicability	155
11.3.3.1.2	Minimum Requirement	155
11.3.3.1.3	Test Purpose	155
11.3.3.1.4	Method of test.....	156
11.3.3.1.4.1	Initial conditions	156
11.3.3.1.4.2	Procedure	156
11.3.3.1.5	Test requirement	157
11.3.3.2	UCI BLER performance requirements.....	157
11.3.3.2.1	Definition and applicability	157
11.3.3.2.2	Minimum Requirement	157
11.3.3.2.3	Test Purpose	157
11.3.3.2.4	Method of test.....	157
11.3.3.2.4.1	Initial conditions	157
11.3.3.2.4.2	Procedure	158
11.3.3.2.5	Test requirement	159
11.3.4	Performance requirements for PUCCH format 3.....	159
11.3.4.1	Definition and applicability.....	159
11.3.4.2	Minimum requirement	159
11.3.4.3	Test purpose	159
11.3.4.4	Method of test	159
11.3.4.4.1	Initial conditions	159
11.3.4.4.2	Procedure.....	160
11.3.4.5	Test requirement	160
11.3.4.5.1	Test requirement for <i>SAN type I-O</i>	160
11.3.5	Performance requirements for PUCCH format 4.....	161
11.3.5.1	Definition and applicability.....	161
11.3.5.2	Minimum requirement	161
11.3.5.3	Test purpose	161
11.3.5.4	Method of test	161
11.3.5.4.1	Initial conditions	161
11.3.5.4.2	Procedure.....	161
11.3.5.5	Test requirement	162
11.3.5.5.1	Test requirement for <i>SAN type I-O</i>	162
11.3.6	Performance requirements for multi-slot PUCCH format	163
11.3.6.1	Performance requirements for multi-slot PUCCH format 1	163
11.3.6.1.1	NACK to ACK detection.....	163
11.3.6.1.1.1	Definition and applicability	163
11.3.6.1.1.2	Minimum Requirement	163
11.3.6.1.1.3	Test purpose	163
11.3.6.1.1.4	Method of test	163
11.3.6.1.1.4.1	Initial conditions.....	163
11.3.6.1.1.4.2	Procedure.....	163
11.3.6.1.1.5	Test Requirement	164
11.3.6.1.2	ACK missed detection.....	165
11.3.6.1.2.1	Definition and applicability	165

11.3.6.1.2.2	Minimum Requirement.....	165
11.3.6.1.2.3	Test purpose.....	165
11.3.6.1.2.4	Method of test.....	165
11.3.6.1.2.4.1	Initial Conditions.....	165
11.3.6.1.2.4.2	Procedure.....	165
11.3.6.1.2.5	Test Requirement.....	166
11.4	OTA performance requirements for PRACH.....	167
11.4.1	PRACH false alarm probability and missed detection.....	167
11.4.1.1	Definition and applicability.....	167
11.4.1.2	Minimum requirement.....	167
11.4.1.3	Test purpose.....	168
11.4.1.4	Method of test.....	168
11.4.1.4.1	Initial conditions.....	168
11.4.1.4.2	Procedure.....	168
11.4.1.5	Test requirement.....	169
Annex A (normative): Reference measurement channel		171
A.1	Fixed Reference Channels for RF Rx requirement (QPSK, R=1/3).....	171
A.2	Fixed Reference Channels for dynamic range (16QAM, R=2/3).....	171
A.3	Fixed Reference Channels for performance requirements (QPSK, R=308/1024).....	172
A.4	PRACH test preambles.....	174
Annex B (informative): Environmental requirements for the SAN equipment		175
B.1	General.....	175
B.2	Normal test environment.....	175
B.2.1	Normal test environment for SPRF.....	175
B.2.2	Normal test environment for SAN terrestrial equipment.....	175
B.3	Void.....	176
B.4	Vibration.....	176
B.5	Measurement of test environment.....	176
Annex C (informative): Test tolerances and derivation of test requirements.....		177
C.1	Measurement of transmitter.....	177
C.2	Measurement of receiver.....	178
C.3	Measurement of performance requirements.....	180
Annex D (informative): Measurement system set-up.....		182
D.1	SAN type 1-H transmitter.....	182
D.1.1	SAN output power, output power dynamics, frequency error, EVM, unwanted emissions for SAN type 1-H.....	182
D.1.2	Transmitter intermodulation for SAN type 1-H.....	183
D.1.3	Transmitter spurious emissions for SAN type 1-H.....	183
D.1.4	Time alignment error for SAN type 1-H.....	184
D.2	SAN type 1-H receiver.....	184
D.2.1	Reference sensitivity level for SAN type 1-H.....	184
D.2.2	Receiver dynamic range for SAN type 1-H.....	185
D.2.3	Receiver adjacent channel selectivity and narrowband blocking for SAN type 1-H.....	185
D.2.4	Receiver spurious emissions.....	185
D.2.5	Receiver In-channel selectivity for SAN type 1-H.....	186
D.2.6	Receiver intermodulation for SAN type 1-H.....	186
D.3	SAN type 1-H and type 1-O transmitter.....	186
D.3.1	Radiated transmit power, output power, output power dynamics, transmitted signal quality, OTA unwanted emissions, OTA transmitter spurious emissions.....	187

D.4	SAN type 1-H and type 1-O receiver	187
D.4.1	OTA sensitivity and OTA reference sensitivity level.....	188
D.4.2	OTA dynamic range, OTA ACS, OTA ICS	188
D.4.3	OTA out-of-band blocking	189
D.5	Void.....	189
D.6	SAN type 1-H performance requirements	190
D.6.1	Performance requirements for PUSCH, single user PUCCH, PRACH on single antenna port in multipath fading conditions	190
D.6.2	Performance requirements for PUSCH and PRACH in static conditions	191
D.6.3	Performance requirements for UL timing adjustment	192
D.7	SAN type 1-O performance requirements	192
Annex E (normative): Characteristic of interfering signal.....		194
Annex F (normative): Void		194
Annex G (normative): Propagation conditions.....		195
G.1	Static propagation condition.....	195
G.2	Multi-path fading propagation conditions	195
G.2.1	Delay profiles	195
G.2.1.1	Delay profiles for FR1-NTN.....	196
G.2.2	Combinations of channel model parameters	196
G.2.3	MIMO channel correlation matrices.....	196
G.2.3.1	MIMO correlation matrices using Uniform Linear Array	196
G.2.3.1.1	Definition of MIMO correlation matrices	197
G.2.3.1.2	MIMO correlation matrices at high, medium and low level	197
G.3	Moving propagation conditions.....	198
Annex H (normative): In-channel Tx test		199
H.1	General	199
H.2	Basic principles	199
H.2.1	Output signal of the TX under test	199
H.2.2	Ideal signal	199
H.2.3	Measurement results.....	200
H.2.4	Measurement points	200
H.3	Pre-FFT minimization process	201
H.4	Timing of the FFT window	201
H.5	Resource element TX power	202
H.6	Post-FFT equalisation.....	203
H.7	EVM.....	204
H.7.0	General	204
H.7.1	Averaged EVM (FDD).....	205
Annex I (informative): Change history.....		206
History		211